


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/998,160	ORII, SHIGEO	
	Examiner	Art Unit	
	Jason Mitchell	2193	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
717	149			717	124	129				
INTERNATIONAL CLASSIFICATION										
G	0	6	F	9/44						
				/						
				/						
				/						
				/						
JASON MITCHELL (Assistant Examiner) 8-8-05 (Date)				KAKALI CHAKI SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Primary Examiner) 8-8-05 (Date)				Total Claims Allowed: 18		
Heem Ceeh 8/29/05 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. 2	

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			121			151			181
2	2			32			62			122			152			182
	3			33			63			123			153			183
	4			34			64			124			154			184
3	5			35			65			125			155			185
	6			36			66			126			156			186
4	7			37			67			127			157			187
5	8			38			68			128			158			188
	9			39			69			129			159			189
6	10			40			70			130			160			190
7	11			41			71			131			161			191
8	12			42			72			132			162			192
	13			43			73			133			163			193
	14			44			74			134			164			194
9	15			45			75			135			165			195
	16			46			76			136			166			196
10	17			47			77			137			167			197
11	18			48			78			138			168			198
	19			49			79			139			169			199
13	20			50			80			140			170			200
14	21			51			81			141			171			201
15	22			52			82			142			172			202
	23			53			83			143			173			203
	24			54			84			144			174			204
16	25			55			85			145			175			205
	26			56			86			146			176			206
17	27			57			87			147			177			207
18	28			58			88			148			178			208
	29			59			89			149			179			209
19	30			60			90			150			180			210